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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

.HARADA ET AL.

Atty. Ref.: 4923-2

Serial No. Unknown

TC/A.U.: Unknown

Filed: July 6, 2006

Examiner: Unknown

For: INTERFEROMETER

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July 6, 2006

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

## INFORMATION DISCLOSURE STATEMENT

As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO/SB/08a. A copy of each listed foreign patent document and article is attached.

This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited.

The Examiner is requested to initial the attached form PTO/SB/08a and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

NIXON & VANDERHYE P.C.

Reg. No. 29,366

HWB:jsm 901 North Glebe Road, 11th Floor

Arlington, VA 22203-1808 Telephone: (703) 816-4000 Facsimile: (703) 816-4100

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		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO	
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\*Examiner Date Considered